

Notice of References Cited	Application/Control No. 09/985,769		Applicant(s)/Patent Under Reexamination ITOH, KEISHIROU	
	Examiner Joseph F Edell		Art Unit 3636	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,795,019	08-1998	Wieclawski, Stanislaw Andrzej	297/216.12
	B	US-			
	C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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